

# BTA208X-1000C

# Three quadrant triacs high commutation

Rev. 01 — 4 October 2005

**Product data sheet** 

## 1. Product profile

### 1.1 General description

Passivated high voltage, high commutation triac in a full pack, plastic package. This triac is intended for use in motor control circuits where high blocking voltage, high static and dynamic dV/dt as well as high dl/dt can occur. This device will commutate the full rated RMS current at the maximum rated junction temperature, without the aid of a snubber.

#### 1.2 Features

- False trigger immunity
- 1000 V V<sub>DRM</sub> guaranteed
- Isolated package

## 1.3 Applications

Motor control

Reversible induction motors

#### 1.4 Quick reference data

- $I_{TSM} \le 65 \text{ A}$
- V<sub>DRM</sub> ≤ 1000 V

- $I_{T(RMS)} \le 8 A$
- I<sub>GT</sub>  $\leq$  35 mA

# 2. Pinning information

Table 1: Pinning

Pin	Description	Simplified outline	Symbol
	· · · · · · · · · · · · · · · · · · ·	Ompinica datinic	oyiiiboi
1	main terminal 1 (T1)		NI
2	main terminal 2 (T2)	mb	T2T1
3	gate (G)		sym051
mb	mounting base; isolated		
		SOT186A (3-lead TO-22	0F)





# 3. Ordering information

#### **Table 2: Ordering information**

Type number	Package		
	Name	Description	Version
BTA208X-1000C	TO-220F	plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 3-lead TO-220 'full pack'	SOT186A

# 4. Limiting values

#### Table 3: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DRM}$	repetitive peak off-state voltage		-	1000	V
I <sub>T(RMS)</sub>	RMS on-state current	full sine wave; $T_h \le 73$ °C; see Figure 4 and 5	-	8	Α
I <sub>TSM</sub>	non-repetitive peak on-state current	full sine wave; $T_j = 25$ °C prior to surge; see Figure 2 and 3			
		t = 20 ms	-	65	Α
		t = 16.7 ms	-	71	Α
I <sup>2</sup> t	I <sup>2</sup> t for fusing	t = 10 ms	-	21	A <sup>2</sup> s
dl <sub>T</sub> /dt	rate of rise of on-state current	$I_{TM} = 12 \text{ A}; I_G = 0.2 \text{ A};$ $dI_G/dt = 0.2 \text{ A}/\mu\text{s}$	-	100	A/μs
I <sub>GM</sub>	peak gate current		-	2	Α
P <sub>GM</sub>	peak gate power		-	5	W
P <sub>G(AV)</sub>	average gate power	over any 20 ms period	-	0.5	W
T <sub>stg</sub>	storage temperature		-40	+150	°C
Tj	junction temperature		-	125	°C

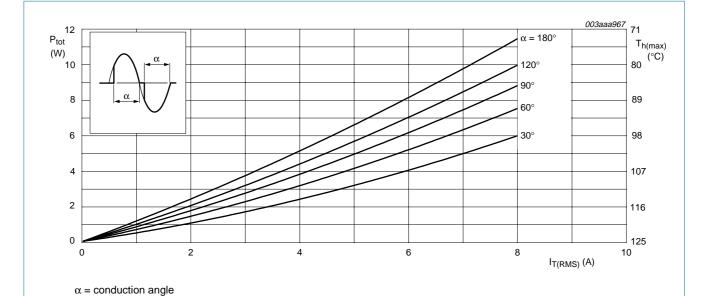


Fig 1. Total power dissipation as a function of RMS on-state current; maximum values

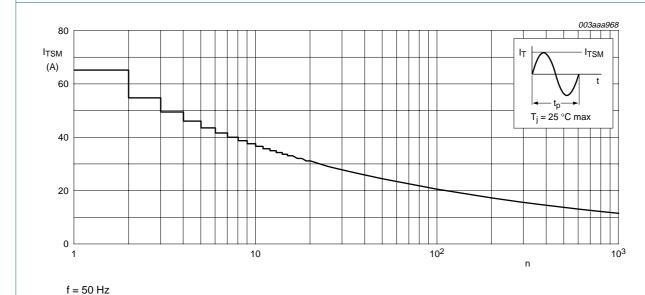


Fig 2. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values

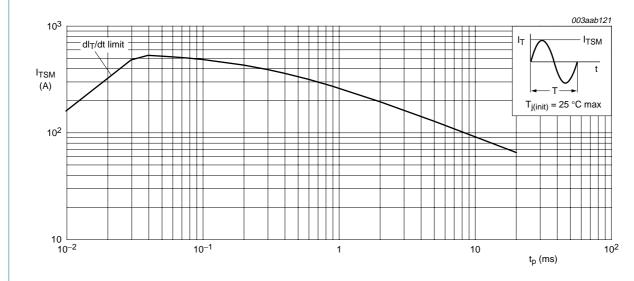


Fig 3. Non-repetitive peak on-state current as a function of pulse width; maximum values

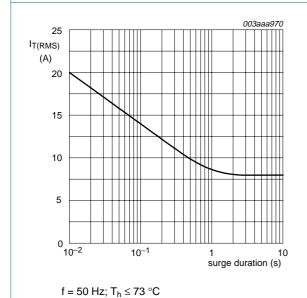


Fig 4. RMS on-state current as a function of surge duration; maximum values

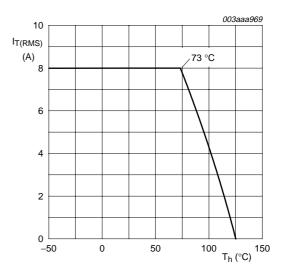


Fig 5. RMS on-state current as a function of heatsink temperature; maximum values

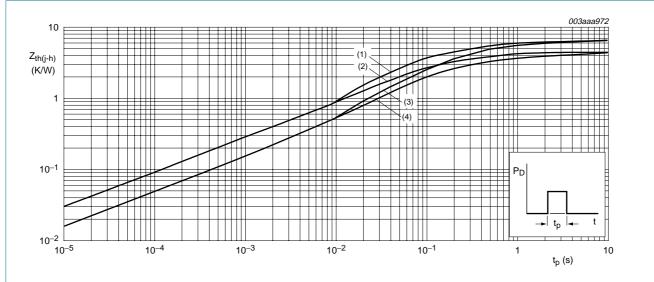


## 5. Thermal characteristics

Table 4: Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-h)</sub>	thermal resistance from junction to heatsink	see Figure 6	<u>[1]</u> _	-	4.5	K/W
		see Figure 6	[2]	-	6.5	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	in free air	-	55	-	K/W

- [1] Full or half cycle; with heatsink compound.
- [2] Full or half cycle; without heatsink compound.



- (1) Unidirectional without heatsink compound
- (2) Unidirectional with heatsink compound
- (3) Bidirectional without heatsink compound
- (4) Bidirectional with heatsink compound

Fig 6. Transient thermal impedance from junction to heatsink as a function of pulse width

### 6. Isolation characteristics

Table 5: Isolation limiting values and characteristics

 $T_h = 25 \,^{\circ}C$  unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>isol(rms)</sub>	RMS isolation voltage	f = 50 Hz to 60 Hz; sinusoidal waveform; RH ≤ 65 %; clean and dust free; from all three terminals to external heatsink	-	-	2500	V
C <sub>isol</sub>	isolation capacitance	f = 1 MHz; from pin 2 to external heatsink	-	10	-	pF



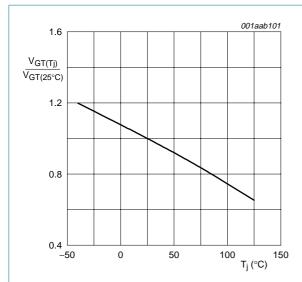
# 7. Characteristics

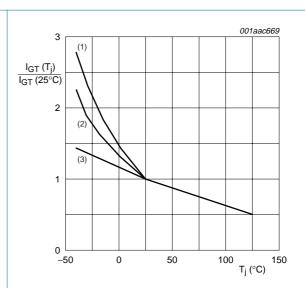
**Table 6: Characteristics** 

 $T_i = 25 \,^{\circ}C$  unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static char	acteristics					
I <sub>GT</sub>	gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; \text{ see } \frac{\text{Figure 8}}{}$	[1]			
		T2+ G+	2	6	35	mA
		T2+ G-	2	13	35	mA
		T2- G-	2	23	35	mA
I <sub>L</sub>	latching current	$V_D = 12 \text{ V; } I_{GT} = 0.1 \text{ A; see}$ Figure 10				
		T2+ G+	-	25	50	mA
		T2+ G-	-	48	75	mA
		T2- G-	-	30	50	mA
I <sub>H</sub>	holding current	$V_D = 12 \text{ V; } I_{GT} = 0.1 \text{ A; see}$ Figure 11	-	20	50	mA
V <sub>T</sub>	on-state voltage	I <sub>T</sub> = 10 A; see <u>Figure 9</u>	-	1.3	1.65	V
$V_{GT}$	gate trigger voltage	$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; see } \frac{\text{Figure 7}}{}$	-	0.7	1.5	V
		$V_D = 400 \text{ V}; I_T = 0.1 \text{ A}; T_j = 125 ^{\circ}\text{C}$	0.25	0.4	-	V
I <sub>D</sub>	off-state current	$V_D = V_{DRM(max)}$ ; $T_j = 125  ^{\circ}C$	-	0.1	0.5	mA
Dynamic c	haracteristics					
dV <sub>D</sub> /dt	rate of rise of off-state voltage	$V_{DM} = 67 \% V_{DRM(max)};$ $T_j = 125 ^{\circ}C;$ exponential waveform; gate open circuit	1000	4000	-	V/µs
dl <sub>com</sub> /dt	rate of change of commutating current	$V_{DM} = 400 \text{ V}; T_j = 125 ^{\circ}\text{C};$ $I_{T(RMS)} = 8 \text{ A};$ without snubber; gate open circuit; see Figure 12	12	32	-	A/ms
t <sub>gt</sub>	gate-controlled turn-on time	$I_{TM} = 12 \text{ A}; V_D = V_{DRM(max)};$ $I_G = 0.1 \text{ A}; dI_G/dt = 5 \text{ A}/\mu\text{s}$	-	2	-	μs

<sup>[1]</sup> Device will not trigger in the T2- G+ quadrant.

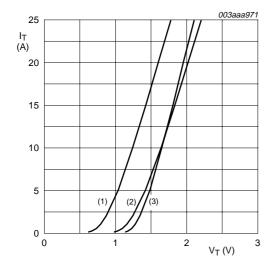




- (1) T2-G-
- (2) T2+ G-
- (3) T2+ G+

Fig 7. Normalized gate trigger voltage as a function of junction temperature







- (1)  $T_i = 125 \,^{\circ}C$ ; typical values
- (2) T<sub>i</sub> = 125 °C; maximum values
- (3)  $T_i = 25 \,^{\circ}C$ ; maximum values

Fig 9. On-state current as a function of on-state voltage

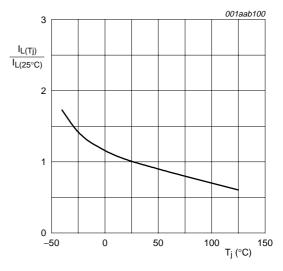


Fig 10. Normalized latching current as a function of junction temperature

## Three quadrant triacs high commutation

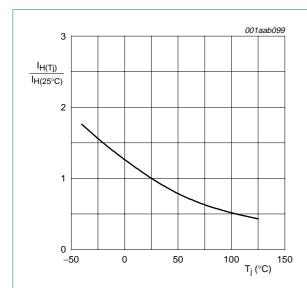


Fig 11. Normalized holding current as a function of junction temperature

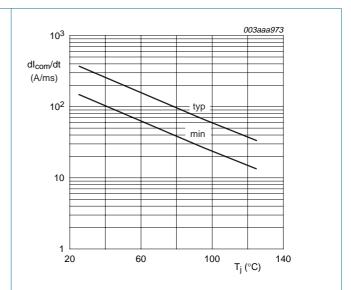


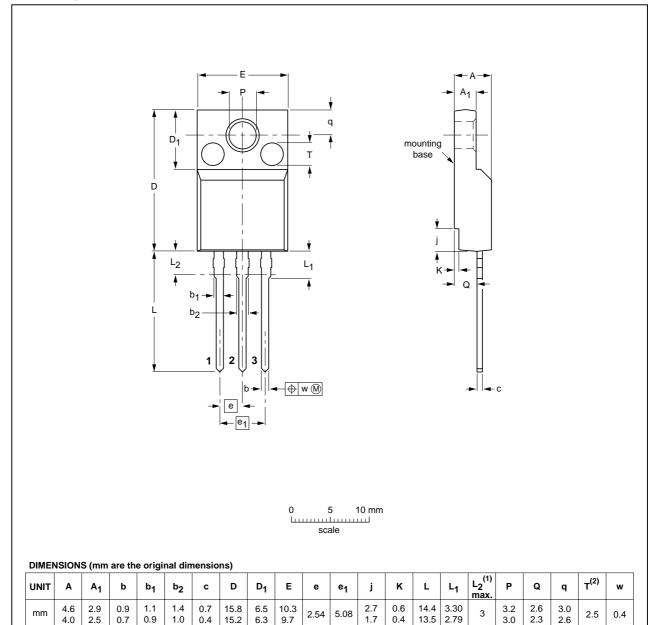
Fig 12. Rate of change of commutating current as a function of junction temperature; typical and minimum values

# 8. Package outline

Plastic single-ended package; isolated heatsink mounted;

1 mounting hole; 3 lead TO-220 'full pack'

SOT186A



#### Notes

- 1. Terminal dimensions within this zone are uncontrolled. Terminals in this zone are not tinned.
- 2. Both recesses are  $\varnothing$  2.5  $\times$  0.8 max. depth

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC JEIT	JEITA	PROJECTION	1990E DATE	
SOT186A		3-lead TO-220F			<del>02-03-12</del> 02-04-09	

Fig 13. Package outline SOT186A (3-lead TO-220F)

BTA208X-1000C\_1

© Koninklijke Philips Electronics N.V. 2005. All rights reserved.





# 9. Revision history

### Table 7: Revision history

Document ID	Release date	Data sheet status	Change notice	Doc. number	Supersedes
BTA208X-1000C_1	20051004	Product data sheet	-	-	-

#### Three quadrant triacs high commutation



Level	Data sheet status [1]	Product status [2] [3]	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
II	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
III	Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN).

- [1] Please consult the most recently issued data sheet before initiating or completing a design.
- [2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.
- [3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

#### 11. Definitions

**Short-form specification** — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

**Application information** — Applications that are described herein for any of these products are for illustrative purposes only. Philips Semiconductors make no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

#### 12. Disclaimers

**Life support** — These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips Semiconductors

customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips Semiconductors for any damages resulting from such application.

Right to make changes — Philips Semiconductors reserves the right to make changes in the products - including circuits, standard cells, and/or software - described or contained herein in order to improve design and/or performance. When the product is in full production (status 'Production'), relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN). Philips Semiconductors assumes no responsibility or liability for the use of any of these products, conveys no license or title under any patent, copyright, or mask work right to these products, and makes no representations or warranties that these products are free from patent, copyright, or mask work right infringement, unless otherwise specified.

#### 13. Trademarks

**Notice** — All referenced brands, product names, service names and trademarks are the property of their respective owners.

#### 14. Contact information

For additional information, please visit: http://www.semiconductors.philips.com
For sales office addresses, send an email to: sales.addresses@www.semiconductors.philips.com

# **Philips Semiconductors**

# BTA208X-1000C

### Three quadrant triacs high commutation

## 15. Contents

1	Product profile
1.1	General description
1.2	Features
1.3	Applications
1.4	Quick reference data
2	Pinning information 1
3	Ordering information 2
4	Limiting values 2
5	Thermal characteristics 5
6	Isolation characteristics 5
7	Characteristics 6
8	Package outline 9
9	Revision history
10	Data sheet status
11	Definitions
12	Disclaimers 11
13	Trademarks 11
14	Contact information 11



All rights are reserved. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. The information presented in this document does not form part of any quotation or contract, is believed to be accurate and reliable and may be changed without notice. No liability will be accepted by the publisher for any consequence of its use. Publication thereof does not convey nor imply any license under patent- or other industrial or intellectual property rights.

